

General testing problem $(\theta \in \Theta)$

$$H_0: \theta \in \Theta_0, \quad \text{v.s.} \quad H_1: \theta \notin \Theta_0.$$

$$(\Theta_0 \subseteq \Theta)$$

- Analogy to estimation: MLE
- For testing: Likelihood Ratio Test.

Idea: compare MLE under Θ_0 and Θ .

the
likelihood values
of

If H_0 is false and θ is
bounded away from Θ_0

Then

$$\max_{\theta \in \Theta} \sum_{i=1}^n \log p_{\theta}(X_i) \gg \max_{\theta \in \Theta_0} \sum_{i=1}^n \log p_{\theta}(X_i).$$

• $LHS \geq RHS$ always true

• For $\theta \notin \mathcal{H}_0$.

$$LHS \approx n \cdot \max_{\theta \in \mathcal{H}} E[\log p_{\theta}(X)]$$

$$RHS \approx n \cdot \max_{\theta \in \mathcal{H}_0} E[\log p_{\theta}(X)].$$

$$LHS - RHS \approx n.$$

• For $\theta \in \mathcal{H}_0$.

$$LHS - RHS = O(1).$$

$$\lambda := 2 \log \left(\sup_{\theta \in \mathcal{H}} p_{\theta}(X_1^n) \right) - 2 \log \left(\sup_{\theta \in \mathcal{H}_0} p_{\theta}(X_1^n) \right)$$

Reject when $\lambda \geq \lambda_{\alpha}$.

Thm: $\mathcal{H} = \mathbb{R}^d$, $\mathcal{H}_0$ $(d-k)$ -dim linear subspace.

(eg. $\mathcal{H}_0$: $\theta_1 = z_1, \theta_2 = z_2, \dots, \theta_k = z_k$)
for some fixed $z_1, z_2, \dots, z_k$).

under the null, assuming some regularity conditions (non-degenerate Fisher info, 2nd order smoothness)

(Basically conditions needed for asymp norm of MLE).

We have $\lambda \xrightarrow{d} \chi^2_k$.

(a χ^2_k distr is the prob. distr. of $\sum_{i=1}^k g_i^2$ where $g_i \sim N(0,1)$).

Operationally.

- Compute unconstrained $\hat{\theta}_n$ and constrained $\hat{\theta}_{n0}$
- Compute λ by comparing the likelihood values.
- Reject when $\lambda \geq (1-\alpha)$ quantile of χ^2_k .

Proof idea: Taylor expansion. (for $\|\theta^* - \theta\| = O_p(\frac{1}{\sqrt{n}})$)

$$\underbrace{\left(\sum_{i=1}^n \log p_{\theta^*}(X_i) \right)}_{\text{Fixed, indep of } \theta} = \underbrace{\left(\sum_{i=1}^n \log p_{\theta}(X_i) \right)}_{\text{want to use in testing}} + \left(\sum_{i=1}^n \nabla \log p_{\theta}(X_i) \right)^T (\theta^* - \theta) + \frac{1}{2} (\theta^* - \theta)^T \left(\sum_{i=1}^n \nabla^2 \log p_{\theta}(X_i) \right) (\theta^* - \theta) + o_p(1).$$

For unconstrained MLE, $\sum_{i=1}^n \nabla \log p_{\hat{\theta}_n}(X_i) = 0$

$$\text{and } \sqrt{n}(\hat{\theta}_n - \theta^*) \xrightarrow{d} N(0, I(\theta^*)^{-1}).$$

We also have

$$\frac{1}{n} \sum_{i=1}^n \nabla^2 \log p_{\hat{\theta}_n}(X_i) \xrightarrow{P} \mathbb{E}_{\theta^*} [\nabla^2 \log p_{\theta^*}(X)] \parallel - I(\theta^*).$$

$$\begin{aligned} \sum_{i=1}^n \log p_{\hat{\theta}_n}(X_i) &= \sum_{i=1}^n \log p_{\theta^*}(X_i) \\ &\quad + \frac{n}{2} (\hat{\theta}_n - \theta^*)^T I(\theta^*) (\hat{\theta}_n - \theta^*) \\ &\quad + o_p(1) \end{aligned}$$

For constrained case, $\hat{\theta}_{n,0} = \underset{\theta \in \Theta_0}{\operatorname{argmax}} \{ \dots \}$.

$$\left. \begin{aligned} \sum_i \nabla \log p_{\hat{\theta}_{n,0}}(X_i) &\perp \Theta_0 \\ \hat{\theta}_{n,0}, \theta^* &\in \Theta_0 \end{aligned} \right\} \rightarrow \text{inner product} = 0.$$

$$\sum_i^n \log p_{\hat{\theta}_{n,0}}(X_i) = \sum_i^n \log p_{\theta^*}(X_i)$$

$$+ \frac{n}{2} (\hat{\theta}_{n,0} - \theta^*)^T I_0(\theta^*) (\hat{\theta}_{n,0} - \theta^*)$$

$$\sqrt{n} (\hat{\theta}_{n,0} - \theta^*) \xrightarrow{d} \mathcal{N}(0, I_0(\theta^*)^+)$$

(Pseudo-inverse).

$$\lambda \approx n \cdot (\hat{\theta}_n - \theta^*)^T I(\theta^*) (\hat{\theta}_n - \theta^*)$$

$$= n (\hat{\theta}_{n,0} - \theta^*)^T I_0(\theta^*) (\hat{\theta}_{n,0} - \theta^*)$$

$$\sqrt{n} (\hat{\theta}_n - \theta^*) \approx I(\theta^*)^{-1/2} \cdot \xi \quad \xi \sim \mathcal{N}(0, I_d)$$

$$\sqrt{n} (\hat{\theta}_{n,0} - \theta^*) \approx I(\theta^*)^{-1/2} \cdot P_{\Theta_0} \xi$$

where P_{Θ_0} is orthogonal projection onto Θ_0 .

So we get

$$\lambda \approx \|\zeta\|_2^2 - \|P_{\Theta_0}\zeta\|_2^2 = \|P\zeta\|_2^2$$

$\downarrow d$
 χ_k^2 .

Multivariate testing radius.

Detection problem:

$$H_0: \theta = \theta_0$$

$$H_1: \|\theta - \theta_0\| > \varepsilon$$

Want to find smallest possible $\varepsilon > 0$

st. we can make both types of errors small.

$$X_1, X_2, \dots, X_n \stackrel{\text{i.i.d.}}{\sim} \mathcal{N}(\theta, I_d) \quad H_0: \theta = 0.$$

$$\text{Test statistics: } T = \left\| \frac{1}{n} \sum_{i=1}^n X_i \right\|_2^2$$

$$n \cdot T \sim \chi_d^2$$

Reject when $n \cdot T > (1-\alpha)$ quantile of χ_d^2 .

Question: what is the order of magnitude of Σ st. we can make type-II err small as well?

(as a function of n and d)

First guess: $\sqrt{\frac{d}{n}}$?

Since $\mathbb{E}[\|\bar{X}_n - \theta\|_2^2] = \frac{d}{n}$, we have $\|\bar{X}_n - \theta\|_2 \leq C\sqrt{\frac{d}{n}}$ w.h.p.

When $\varepsilon > 2C\sqrt{\frac{d}{n}}$,

under H_1 , $\|\bar{X}_n\|_2 \geq \|\theta\|_2 - \|\bar{X}_n - \theta\|_2 \geq C\sqrt{\frac{d}{n}}$ (w.h.p.).

So we can show that

$$\mathbb{P}_\theta(\text{reject}) \geq \frac{3}{4} \quad \text{when } \|\theta\|_2 > \varepsilon.$$

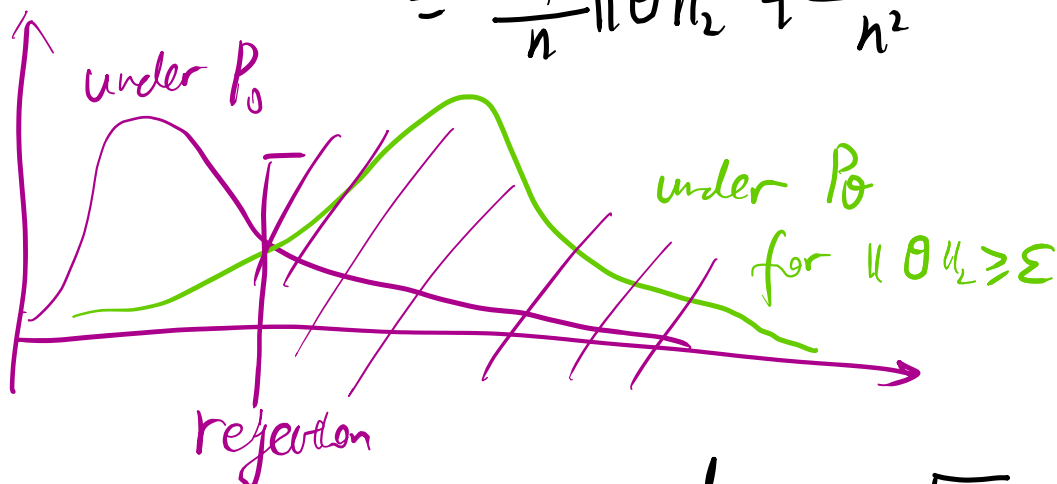
For testing, we can achieve $\varepsilon = C \cdot \frac{d^{1/4}}{n^{1/2}}$.

(Detecting a signal is easier than estimating a signal)

Proof idea: $T = \left\| \frac{1}{n} \sum_{i=1}^n X_i \right\|_2^2 \quad \frac{1}{n} \sum_{i=1}^n X_i \sim \mathcal{N}(\theta, \frac{I_d}{n})$

$$\mathbb{E}_\theta[T] = \|\theta\|_2^2 + \frac{d}{n}.$$

$$\begin{aligned} \text{Var}_\theta(T) &= \sum_{j=1}^d \text{var}\left(\left(\frac{1}{n} \sum_{i=1}^n X_{ij}\right)^2\right) \\ &= \frac{4}{n} \|\theta\|_2^2 + \frac{2d}{n^2} \end{aligned}$$



$$\text{Rejection threshold} = \frac{d}{n} + a \frac{\sqrt{2d}}{n}$$

Under null. by Chebyshev ineq,

$$\begin{aligned} P_0(\text{reject}) &= P_0\left(T > \frac{d}{n} + a \frac{\sqrt{2d}}{n}\right) \\ &\leq \frac{\text{Var}_0(T)}{a \cdot \left(\frac{\sqrt{2d}}{n}\right)^2} = \frac{1}{a^2}. \end{aligned}$$

Under alternative:

$$\begin{aligned} P_\theta(\text{not reject}) &= P_\theta\left(T \leq \frac{d + a\sqrt{2d}}{n}\right) \\ &= P_\theta\left(T - E_\theta[T] \leq \frac{a\sqrt{2d}}{n} - \|\theta\|_2^2\right). \end{aligned}$$

assuming $\Sigma > \left(\frac{a\sqrt{2d}}{n}\right)^{\frac{1}{2}}$

$$\leq \frac{\text{Var}_\theta(T)}{\left(\|\theta\|_2^2 - \frac{a\sqrt{2d}}{n}\right)^2} = \frac{\frac{2d}{n^2} + \frac{4\|\theta\|^2}{n}}{\left(\|\theta\|_2^2 - \frac{a\sqrt{2d}}{n}\right)^2}$$

(want to show $\leq \frac{1}{a^2}$)

Need to have:

$$\|\theta\|_2^2 - \frac{a \overline{Id}}{n} \geq a \sqrt{\frac{4}{n} \|\theta\|_2^2 + \frac{2d}{n^2}}$$

This is satisfied when

$$\|\theta\|_2^2 \geq C(a) \cdot \frac{\overline{Id}}{n}$$

(where $C(a)$ is a const depending only on a).

Remark: testing is useful only when it detects something. We should care about type-II err.

Decision theory:

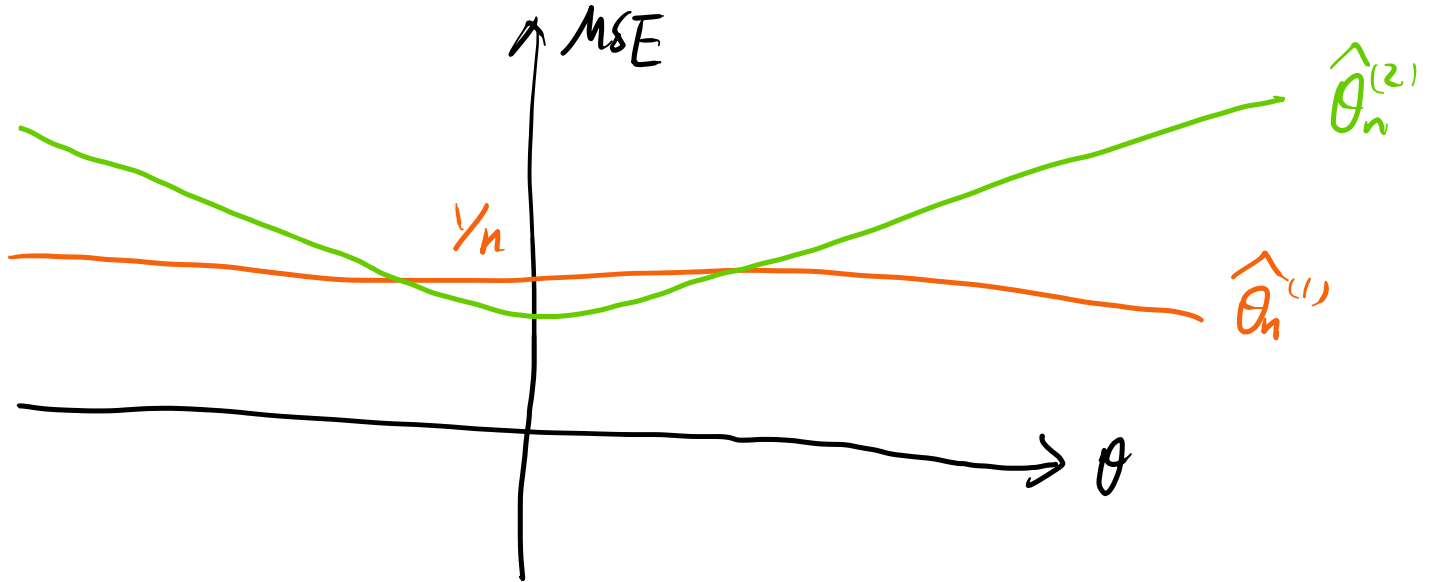
Motivation: How to compare estimators.

eg. $X_1, X_2, \dots, X_n \stackrel{\text{i.i.d.}}{\sim} N(\theta, 1) \quad \theta \in \mathbb{R}$

$$\hat{\theta}_n^{(1)} = \bar{X}_n \quad \mathbb{E}[|\bar{X}_n - \theta|^2] = \frac{1}{n}$$

$$\hat{\theta}_n^{(2)} = \frac{\sum_{i=1}^n X_i}{n+1}$$

$$\begin{aligned}
 & \mathbb{E}[\hat{\theta}_n^{(2)} - \theta]^2 \\
 &= \text{bias}_\theta(\hat{\theta}_n^{(2)})^2 + \text{var}_\theta(\hat{\theta}_n^{(2)}) \\
 &= \left(\frac{\theta}{n+1}\right)^2 + \frac{n}{(n+1)^2} = \frac{n + \theta^2}{(n+1)^2}
 \end{aligned}$$



Unable to uniformly compare.

Notations:

• loss function $L(\theta, \hat{\theta}_n)$ (e.g. $\|\theta - \hat{\theta}_n\|^2$).

• Risk $R(\theta, \hat{\theta}_n) = \mathbb{E}_\theta[L(\theta, \hat{\theta}_n)]$
(e.g. MSE)

Def. "Bayes risk"

π "prior": a prob distribution on Θ

$$r_{\pi}(\hat{\theta}_n) = \int R(\theta, \hat{\theta}_n) \pi(\theta) d\theta.$$

"Bayes estimator":

$$\operatorname{argmin} \{ r_{\pi}(\hat{\theta}_n) \}.$$

Def. "minimax risk".

$$\bar{R}(\hat{\theta}_n) := \sup_{\theta} R(\theta, \hat{\theta}_n).$$

$$\hat{\theta}_n = \operatorname{argmin} \bar{R}(\hat{\theta}_n)$$

"minimax estimator".

How to find Bayes estimator?

Suppose $P_\theta(x)$ is the pdf (or pmf)
of x under P_θ .

$$\begin{aligned} r_\pi(\hat{\theta}_n) &= \int_{\Theta} \int_{\mathcal{X}} L(\theta, \hat{\theta}_n(x)) \cdot P_\theta(x) \cdot \pi(\theta) dx d\theta \\ &= \int_{\mathcal{X}} \left[\int_{\Theta} L(\theta, \hat{\theta}_n(x)) \cdot P_\theta(x) \cdot \pi(\theta) d\theta \right] dx \end{aligned}$$

For fixed $x \in \mathcal{X}$, we can choose
 $\hat{\theta}_n(x)$ to minimize it

$$\hat{\theta}_n(x) = \arg \min_{\psi \in \Theta} \int_{\Theta} L(\theta; \psi) \cdot P_\theta(x) \pi(\theta) d\theta$$

$$= \arg \min_{\psi \in \Theta} \frac{\int_{\Theta} L(\theta; \psi) \cdot P_\theta(x) \pi(\theta) d\theta}{\int_{\Theta} P_\theta(x) \cdot \pi(\theta) d\theta}$$

$$= \arg \min_{\psi \in \Theta} \int_{\Theta} L(\theta; \psi) \pi(\theta | x_1, \dots, x_n) d\theta$$

$$\pi(\theta|x, \dots x_n) := \frac{\pi(\theta) \cdot p_\theta(x)}{\int_{\Theta} p_{\theta'}(x) \cdot \pi(\theta') d\theta'}$$

"Posterior distribution".

Bayesian interpretation:

Assume $\theta \sim \pi$, $X|\theta \sim p_\theta$

By Bayes formula, we can conclude

$$p(\theta|x) = \frac{\pi(\theta) \cdot p_\theta(x)}{\int p_{\theta'}(x) \cdot \pi(\theta') d\theta'} = \pi(d\theta)$$

Bayes estimator = Posterior risk minimizer.

For MSE

$$\hat{\theta} = \arg \min_{\psi \in \Theta} \int_{\Theta} \|\theta - \psi\|_2^2 \cdot \pi(\theta|x) d\theta$$

$$= \int_{\Theta} \theta \cdot \pi(\theta|x) d\theta$$

Posterior mean.

eg. $X_1, X_2, \dots, X_n \stackrel{\text{iid}}{\sim} \mathcal{N}(0, 1)$.

$$\pi = \mathcal{N}(0, 1).$$

$$\pi(\cdot | X_1, \dots, X_n) = \mathcal{N}\left(\frac{\sum_{i=1}^n X_i}{n+1}, \frac{1}{n+1}\right).$$

So $\hat{\theta}_n^{(2)}$ at the beginning
is the Bayes estimator for $\pi = \mathcal{N}(0, 1)$.

How to find minimax estimators?

Fact. const risk Bayes estimators are minimax.

$$\forall \theta_1, \theta_2 \in \Theta \quad R(\theta_1, \hat{\theta}_n) = R(\theta_2, \hat{\theta}_n) (= r_n(\hat{\theta}_n))$$

eg. $X \sim \text{Binom}(n, p)$ known n , estimate p .

"natural choice": $\hat{p} = \frac{X}{n}$.

$$R(p; \hat{p}) = \frac{p(1-p)}{n}.$$